



STB230NH03L

N-channel 30V - 80A - D²PAK
STripFET™ Power MOSFET

Features

| Type | V _{DSS} | R _{DS(on)} | I _D |
|-------------|------------------|---------------------|--------------------|
| STB230NH03L | 30V | < 3mΩ | 80A ⁽¹⁾ |

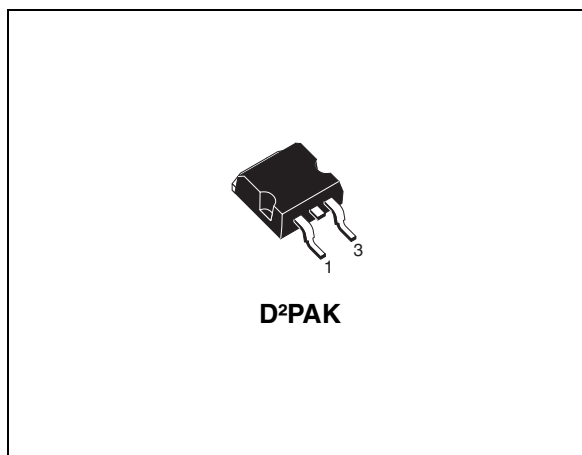
1. This value is limited by package
- R_{DS(on)} Qg industry's benchmark
 - Conduction losses reduced
 - Switching losses reduced
 - Low threshold device

Description

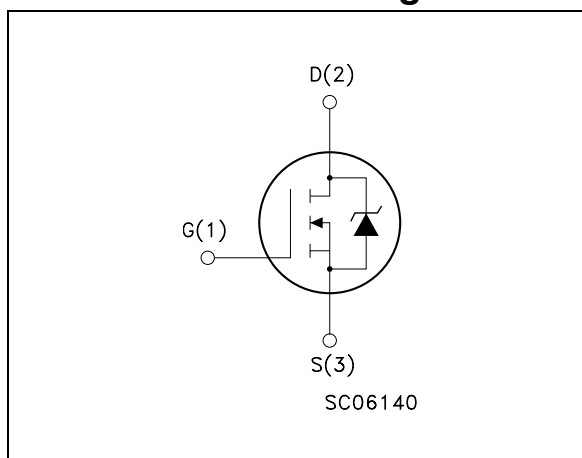
This product utilizes the latest advanced design rules of ST's proprietary STripFET™ technology. This is suitable for the most demanding DC-DC converter application where high efficiency is to be achieved.

Applications

- Switching applications
 - Specifically designed and optimized for high efficiency DC/DC converters
 - OR-ing



Internal schematic diagram



Order code

| Part number | Marking | Package | Packaging |
|-------------|-----------|--------------------|-------------|
| STB230NH03L | B230NH03L | D ² PAK | Tape & reel |

Contents

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1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-----------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage ($V_{GS} = 0$) | 30 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 250 | A |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 178 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 80 | A |
| $I_{DM}^{(3)}$ | Drain current (pulsed) | 1000 | A |
| $P_{TOT}^{(4)}$ | Total dissipation at $T_C = 25^\circ\text{C}$ | 300 | W |
| | Derating factor | 2 | W/ $^\circ\text{C}$ |
| T_J | Operating junction temperature | -55 to 175 | $^\circ\text{C}$ |

1. This value is silicon limited
2. This value is limited by package
3. Pulse width limited by safe operating area
4. This value is rated according to Rthj-c

Table 2. Thermal data

| Symbol | Parameter | Value | Unit |
|------------|--|-------|---------------------------|
| R_{thJC} | Thermal resistance junction-case max | 0.5 | $^\circ\text{C}/\text{W}$ |
| R_{thJA} | Thermal resistance junction-ambient max | 62.5 | $^\circ\text{C}/\text{W}$ |
| T_I | Maximum lead temperature for soldering purpose | 300 | $^\circ\text{C}$ |

Table 3. Avalanche data

| Symbol | Parameter | Value | Unit |
|----------------|-------------------------------|-------|------|
| I_{AS} | Avalanche current | 60 | A |
| $E_{AS}^{(1)}$ | Single pulse avalanche energy | 1150 | mJ |

1. Starting $T_j = 25^\circ\text{C}$, $I_D = I_{AV}$, $V_{DD} = 24\text{V}$

2 Electrical characteristics

($T_{CASE}=25^{\circ}C$ unless otherwise specified)

Table 4. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|------|-----------|--------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 1mA, V_{GS} = 0$ | 30 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = 30V,$ $V_{DS} = 30V, T_c = 125^{\circ}C$ | | | 1 10 | μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 20V$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 1 | 1.5 | 2.5 | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10V, I_D = 40A$ | | 2.3 | 3 | $m\Omega$ |

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|----------|
| C_{iss} | Input capacitance | $V_{DS} = 10V, f = 1 MHz, V_{GS} = 0$ | | 4700 | | pF |
| C_{oss} | Output capacitance | | | 1600 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 85 | | pF |
| Q_g | Total gate charge | $V_{DD} = 15V, I_D = 60A$ | | 72 | | nC |
| Q_{gs} | Gate-source charge | $V_{GS} = 10V$ | | 15 | | nC |
| Q_{gd} | Gate-drain charge | (see Figure 13) | | 11 | | nC |
| R_G | Gate input resistance | $f = 1 MHz$ Gate DC Bias = 0 Test signal level = 20mV open drain | | 5.5 | | Ω |

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------|----------------------------------|--|------|------------|------|----------|
| $t_{d(on)}$ t_r | Turn-on delay time Rise time | $V_{DD}=15V$, $I_D=60A$, $R_G=4.7\Omega$, $V_{GS}=10V$ <i>(see Figure 12)</i> | | 11 322 | | ns ns |
| $t_{d(off)}$ t_f | Turn-off delay time Fall time | $V_{DD}=15V$, $I_D=60A$, $R_G=4.7\Omega$, $V_{GS}=10V$ <i>(see Figure 12)</i> | | 123 102 | | ns ns |

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|---|------|-------------------|-------------|---------------|
| $I_{SD}^{(1)}$ $I_{SDM}^{(2)}$ | Source-drain current Source-drain current (pulsed) | | | | 250 1000 | A A |
| $V_{SD}^{(3)}$ | Forward on voltage | $I_{SD}=40A$, $V_{GS}=0$ | | | 1.3 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}=120A$, $di/dt = 100A/\mu s$, $V_{DD}=20V$, $T_j=25^\circ C$ <i>(see Figure 17)</i> | | 42 34.7 1.6 | | ns nC A |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}=120A$, $di/dt = 100A/\mu s$, $V_{DD}=20V$, $T_j=150^\circ C$ <i>(see Figure 17)</i> | | 47 41.3 1.8 | | ns nC A |

1. This value is silicon limited
2. Pulse width limited by safe operating area
3. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

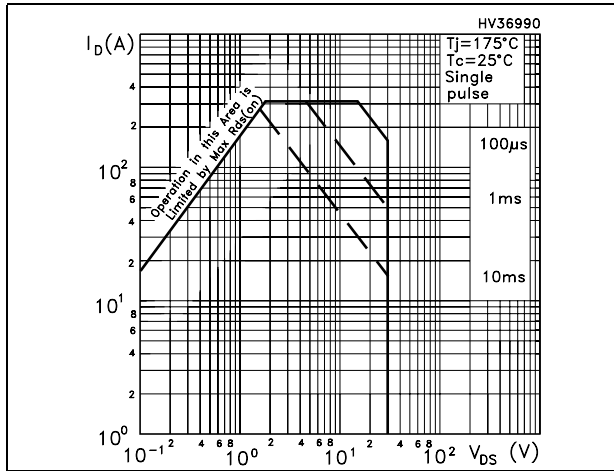


Figure 2. Thermal impedance

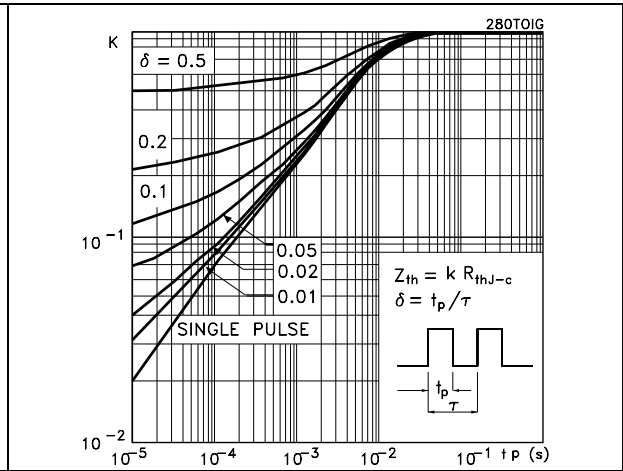


Figure 3. Output characteristics

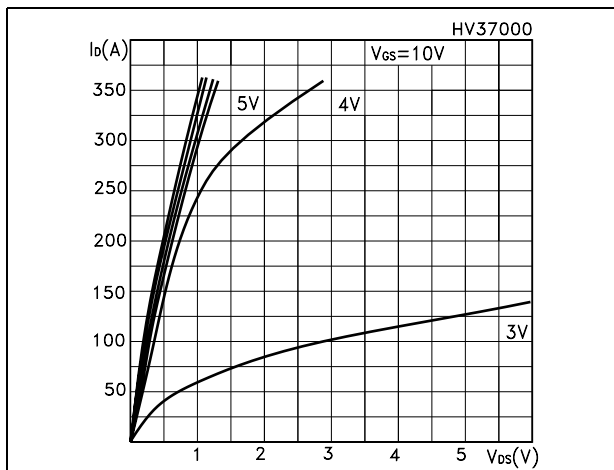


Figure 4. Transfer characteristics

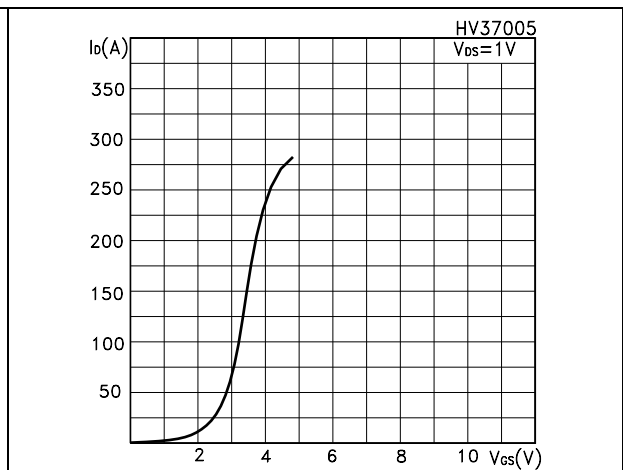


Figure 5. Static drain-source on resistance

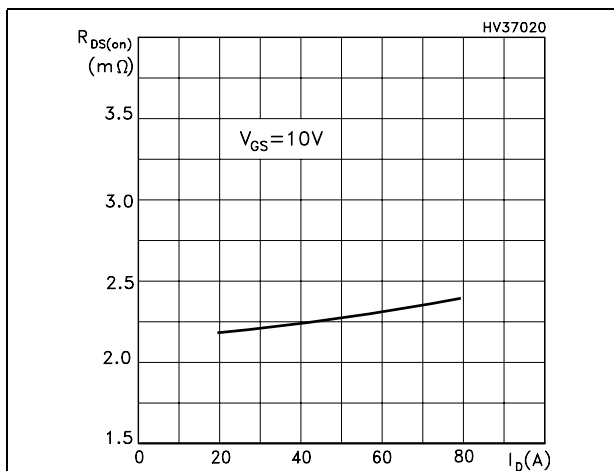


Figure 6. Normalized BV_{DSS} vs temperature

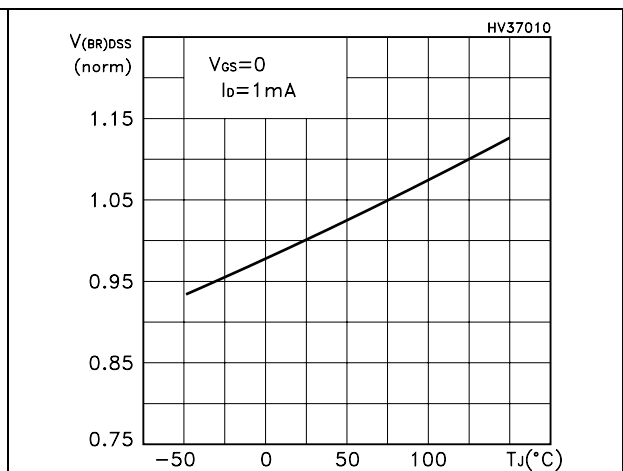


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

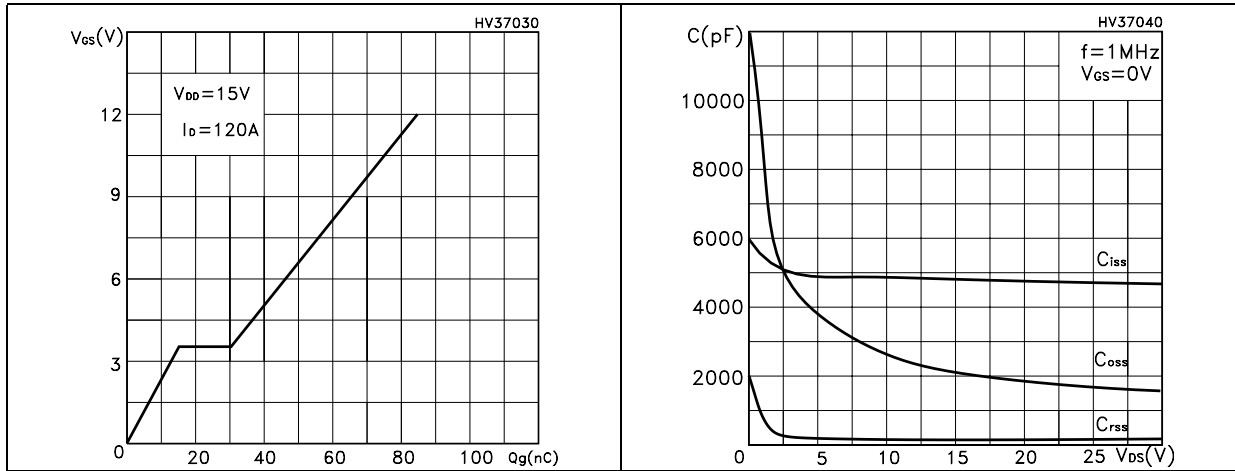


Figure 9. Normalized gate threshold voltage vs temperature Figure 10. Normalized on resistance vs temperature

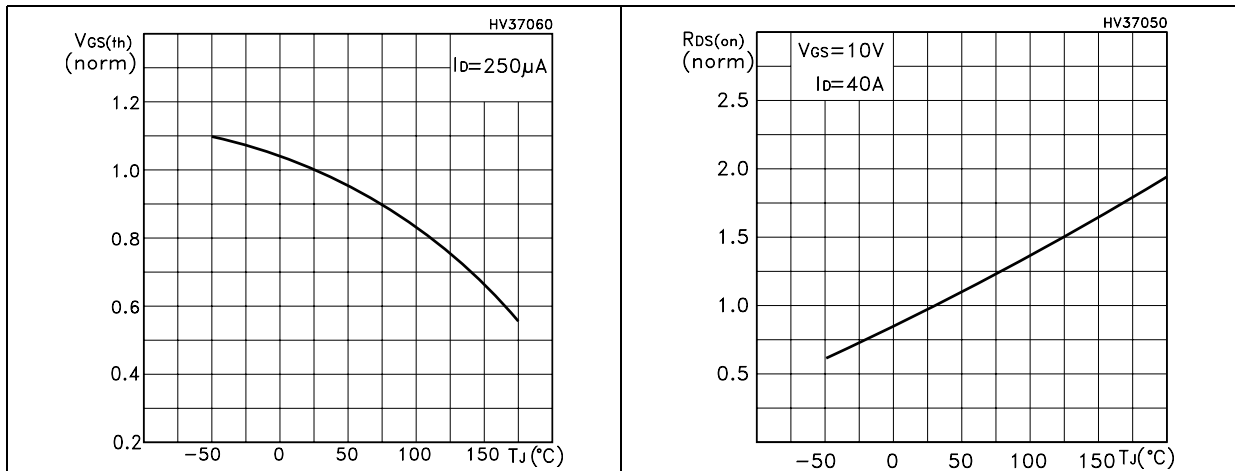
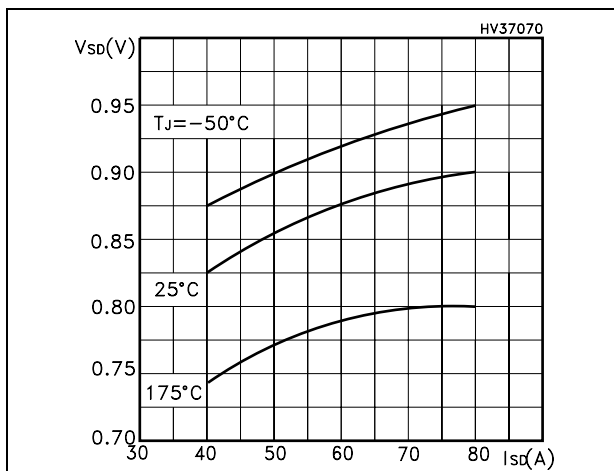


Figure 11. Source-drain diode forward characteristics



3 Test circuit

Figure 12. Switching times test circuit for resistive load

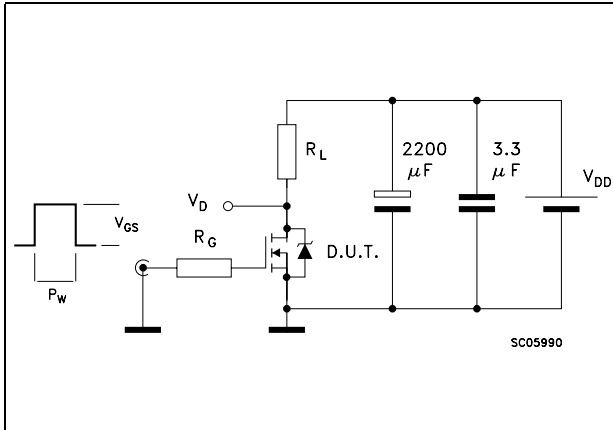


Figure 13. Gate charge test circuit

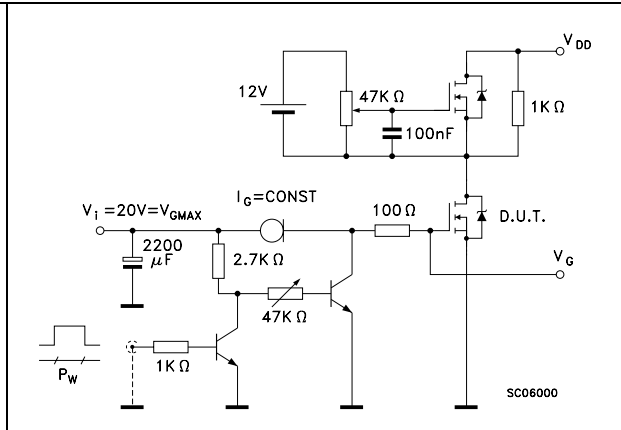


Figure 14. Test circuit for inductive load switching and diode recovery times

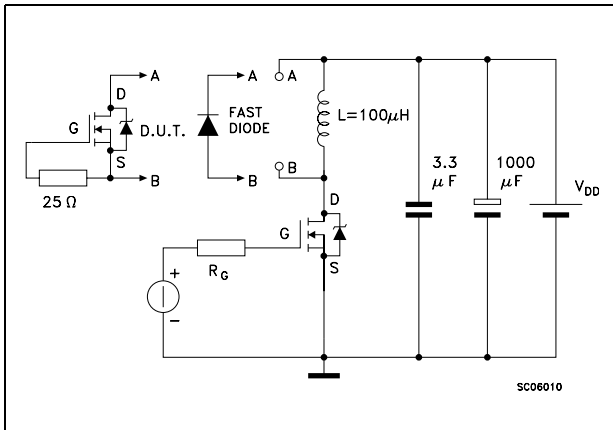


Figure 15. Unclamped Inductive load test circuit

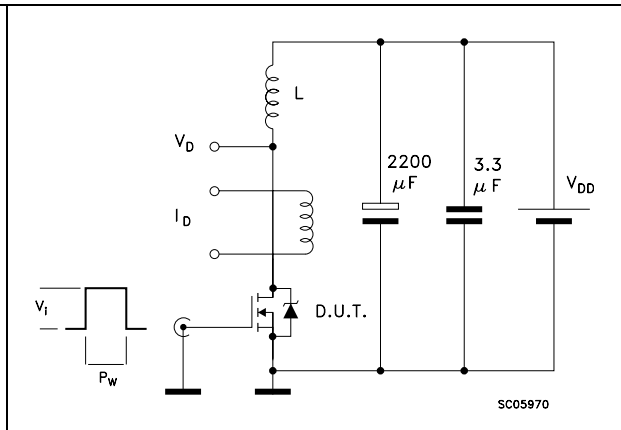


Figure 16. Unclamped inductive waveform

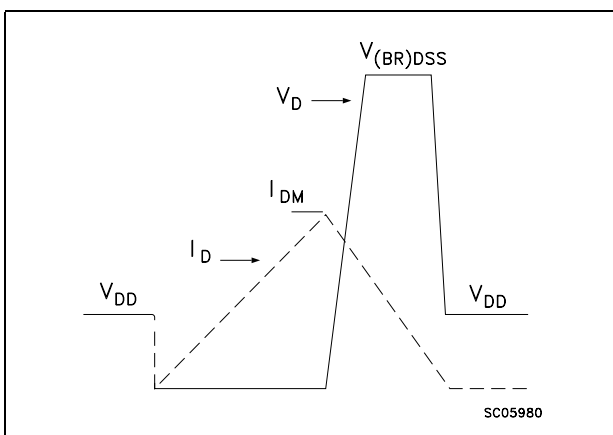
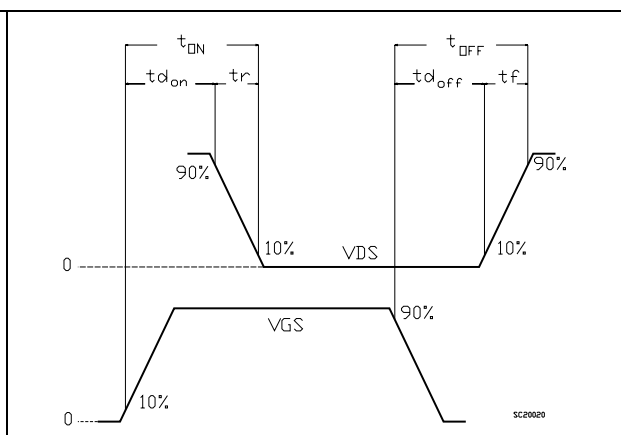


Figure 17. Switching time waveform

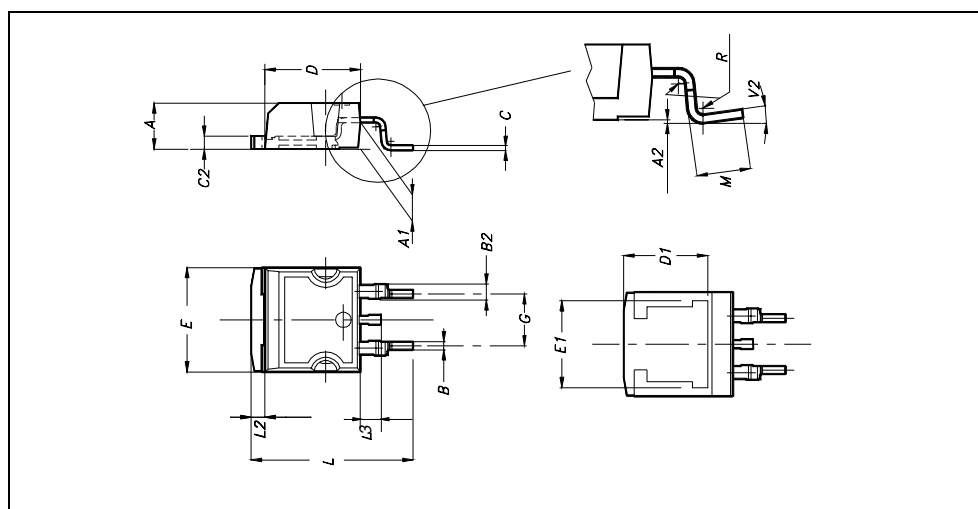


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

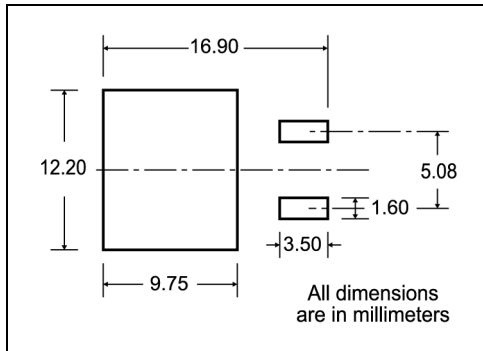
D²PAK MECHANICAL DATA

| DIM. | mm. | | | inch | | |
|------|------|-----|-------|-------|-------|-------|
| | MIN. | TYP | MAX. | MIN. | TYP. | MAX. |
| A | 4.4 | | 4.6 | 0.173 | | 0.181 |
| A1 | 2.49 | | 2.69 | 0.098 | | 0.106 |
| A2 | 0.03 | | 0.23 | 0.001 | | 0.009 |
| B | 0.7 | | 0.93 | 0.027 | | 0.036 |
| B2 | 1.14 | | 1.7 | 0.044 | | 0.067 |
| C | 0.45 | | 0.6 | 0.017 | | 0.023 |
| C2 | 1.23 | | 1.36 | 0.048 | | 0.053 |
| D | 8.95 | | 9.35 | 0.352 | | 0.368 |
| D1 | | 8 | | | 0.315 | |
| E | 10 | | 10.4 | 0.393 | | |
| E1 | | 8.5 | | | 0.334 | |
| G | 4.88 | | 5.28 | 0.192 | | 0.208 |
| L | 15 | | 15.85 | 0.590 | | 0.625 |
| L2 | 1.27 | | 1.4 | 0.050 | | 0.055 |
| L3 | 1.4 | | 1.75 | 0.055 | | 0.068 |
| M | 2.4 | | 3.2 | 0.094 | | 0.126 |
| R | | 0.4 | | | 0.015 | |
| V2 | 0° | | 4° | | | |



5 Packaging mechanical data

D²PAK FOOTPRINT



TAPE AND REEL SHIPMENT

40 mm min. Access hole at slot location

Full radius

Tape slot in core for tape start 2.5mm min. width

G measured at hub

REEL MECHANICAL DATA

| DIM. | mm | | inch | |
|------|------|------|-------|--------|
| | MIN. | MAX. | MIN. | MAX. |
| A | | 330 | | 12.992 |
| B | 1.5 | | 0.059 | |
| C | 12.8 | 13.2 | 0.504 | 0.520 |
| D | 20.2 | | 0.795 | |
| G | 24.4 | 26.4 | 0.960 | 1.039 |
| N | 100 | | 3.937 | |
| T | | 30.4 | | 1.197 |

| BASE QTY | BULK QTY |
|----------|----------|
| 1000 | 1000 |

TAPE MECHANICAL DATA

| DIM. | mm | | inch | |
|------|------|------|--------|--------|
| | MIN. | MAX. | MIN. | MAX. |
| A0 | 10.5 | 10.7 | 0.413 | 0.421 |
| B0 | 15.7 | 15.9 | 0.618 | 0.626 |
| D | 1.5 | 1.6 | 0.059 | 0.063 |
| D1 | 1.59 | 1.61 | 0.062 | 0.063 |
| E | 1.65 | 1.85 | 0.065 | 0.073 |
| F | 11.4 | 11.6 | 0.449 | 0.456 |
| K0 | 4.8 | 5.0 | 0.189 | 0.197 |
| P0 | 3.9 | 4.1 | 0.153 | 0.161 |
| P1 | 11.9 | 12.1 | 0.468 | 0.476 |
| P2 | 1.9 | 2.1 | 0.075 | 0.082 |
| R | 50 | | 1.574 | |
| T | 0.25 | 0.35 | 0.0098 | 0.0137 |
| W | 23.7 | 24.3 | 0.933 | 0.956 |

10 pitches cumulative tolerance on tape +/- 0.2 mm

Center line of cavity

User Direction of Feed

FEED DIRECTION

Bending radius R min.

* on sales type

6 Revision history

Table 8. Revision history

| Date | Revision | Changes |
|-------------|----------|------------------|
| 08-Jun-2007 | 1 | Initial release. |

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